

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <u>www.onsemi.com</u>. Please email any questions regarding the system integration to <u>Fairchild_questions@onsemi.com</u>.

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized applications, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an ad experson



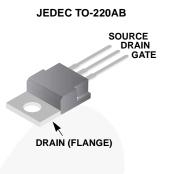
HUF75542P3

Data Sheet

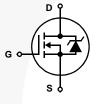
October 2013

N-Channel UltraFET Power MOSFET 80 V, 75 A, 14 mΩ

Packaging



Symbol



Features

- Ultra Low On-Resistance
 - $r_{DS(ON)} = 0.014\Omega, V_{GS} = 10V$
- Simulation Models
 - Temperature Compensated PSPICE® and SABER™ Electrical Models
 - Spice and SABER Thermal Impedance Models
 - www.fairchildsemi.com
- Peak Current vs Pulse Width Curve
- UIS Rating Curve

Ordering Information

PART NUMBER	PACKAGE	BRAND
HUF75542P3	TO-220AB	75542P

Absolute Maximum Ratings	$T_{C} = 25^{\circ}C$, Unless Otherwise Specified
---------------------------------	--

	HUF75542P3	UNITS
Drain to Source Voltage (Note 1)	80	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1)	80	V
Gate to Source Voltage	±20	V
Drain Current Continuous ($T_C = 25^{\circ}C$, $V_{GS} = 10V$) (Figure 2) ID Continuous ($T_C = 100^{\circ}C$, $V_{GS} = 10V$) (Figure 2) ID Pulsed Drain Current IDM Pulsed Avalanche Rating UIS	75 58 Figure 4 Figures 6, 14, 15	A A
Power Dissipation	230 1.54	W W/ ^o C
Operating and Storage Temperature	-55 to 175	°C
Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10sT _L Package Body for 10s, See Techbrief TB334T _{pkg} NOTE:	300 260	°C O

1. $T_J = 25^{\circ}C$ to $150^{\circ}C$.

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Product reliability information can be found at http://www.fairchildsemi.com/products/discrete/reliability/index.html For severe environments, see our Automotive HUFA series.

All Fairchild semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification.

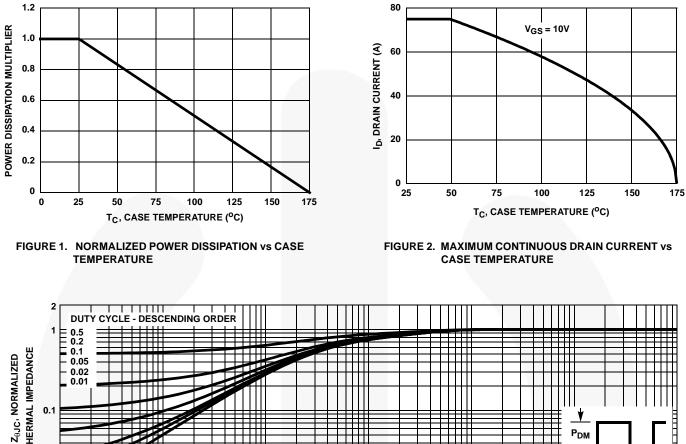
PARAMETER	SYMBOL	TEST CONDITIONS		MIN	ТҮР	MAX	UNITS
OFF STATE SPECIFICATIONS		1					
Drain to Source Breakdown Voltage	BV _{DSS}	I _D = 250∝A, V _{GS} = 0V (Figure 11)		80	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 75V, V _{GS} = 0V		-	-	1	∝A
		$V_{\rm DS} = 70V, V_{\rm GS} = 0V$	/, T _C = 150 ^o C	-	-	250	∝A
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V$		-	-	±100	nA
ON STATE SPECIFICATIONS	1			I	l	1	1
Gate to Source Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} = 250$	∝A (Figure 10)	2	-	4	V
Drain to Source On Resistance	r _{DS(ON)}	I _D = 75A, V _{GS} = 10V	(Figure 9)	-	0.012	0.014	Ω
THERMAL SPECIFICATIONS						1	1
Thermal Resistance Junction to Case	R _{θJC}	TO-220		-	-	0.65	°C/W
Thermal Resistance Junction to Ambient	R _{θJA}			-	-	62	°C/W
SWITCHING SPECIFICATIONS (V_{GS}	= 10V)			I			
Turn-On Time	ton	$V_{DD} = 40V, I_D = 75A$ $V_{GS} = 10V,$ $R_{GS} = 3.9\Omega$ (Figures 18, 19)		-	-	195	ns
Turn-On Delay Time	t _{d(ON)}			-	12.5	-	ns
Rise Time	tr			-	117	-	ns
Turn-Off Delay Time	t _{d(OFF)}			-	50	-	ns
Fall Time	t _f			-	80	-	ns
Turn-Off Time	tOFF			-	-	195	ns
GATE CHARGE SPECIFICATIONS	1						1
Total Gate Charge	Q _{g(TOT)}	$V_{GS} = 0V$ to 20V	$V_{DD} = 40V,$	-	150	180	nC
Gate Charge at 10V	Q _{g(10)}	$V_{GS} = 0V \text{ to } 10V$	I _D = 75A, I _{g(REF)} = 1.0mA	-	80	96	nC
Threshold Gate Charge	Q _{g(TH)}	$V_{GS} = 0V \text{ to } 2V$	(Figures 13, 16, 17)	-	5.7	7	nC
Gate to Source Gate Charge	Q _{gs}	-		-	15	-	nC
Gate to Drain "Miller" Charge	Q _{gd}			-	33		nC
CAPACITANCE SPECIFICATIONS		1		I.		r	
Input Capacitance	C _{ISS}	V _{DS} = 25V, V _{GS} = 0V,		-	2750	-	pF
Output Capacitance	C _{OSS}	f = 1MHz (Figure 12)		-	700	-	pF
Reverse Transfer Capacitance	C _{RSS}			-	250		pF

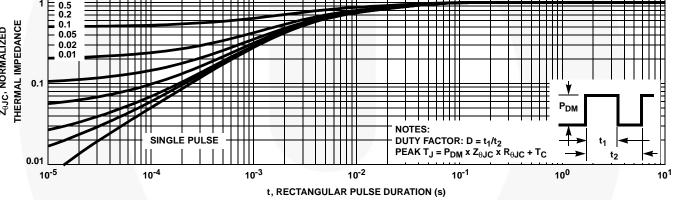
Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	МАХ	UNITS
Source to Drain Diode Voltage	V _{SD}	I _{SD} = 75A	-	-	1.25	V
		I _{SD} = 37.5A	-	-	1.00	V
Reverse Recovery Time	t _{rr}	I _{SD} = 75A, dI _{SD} /dt = 100A/∝s	-	-	102	ns
Reverse Recovered Charge	Q _{RR}	I _{SD} = 75A, dI _{SD} /dt = 100A/∝s	-	-	255	nC

Typical Performance Curves







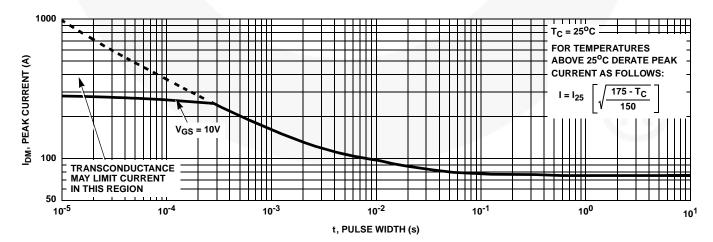


FIGURE 4. PEAK CURRENT CAPABILITY

Typical Performance Curves (Continued)

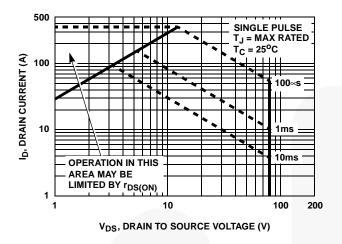


FIGURE 5. FORWARD BIAS SAFE OPERATING AREA

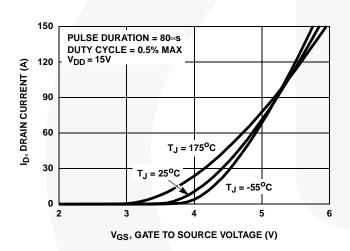
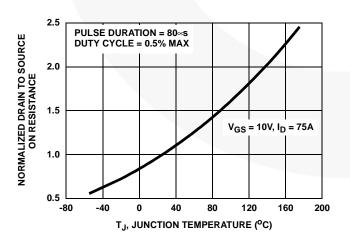
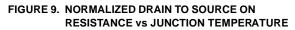
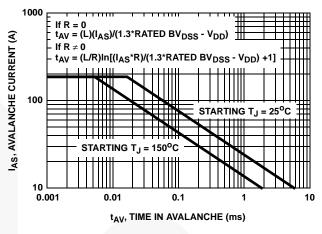


FIGURE 7. TRANSFER CHARACTERISTICS

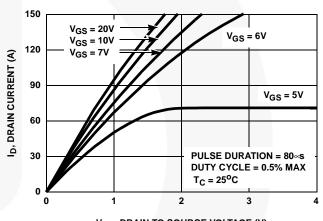






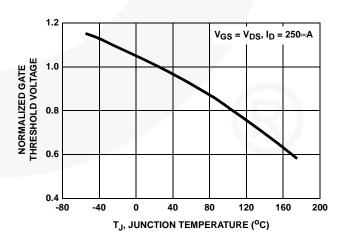
NOTE: Refer to Fairchild Application Notes AN9321 and AN9322. FIGURE 6. UNCLAMPED INDUCTIVE SWITCHING

CAPABILITY



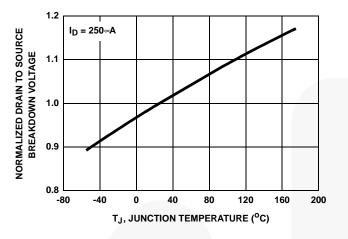
V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

FIGURE 8. SATURATION CHARACTERISTICS





Typical Performance Curves (Continued)





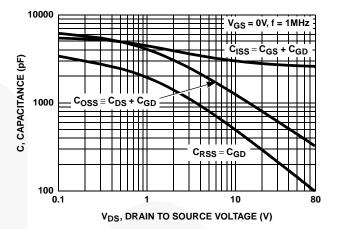
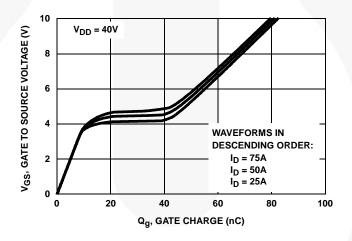


FIGURE 12. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE





Test Circuits and Waveforms

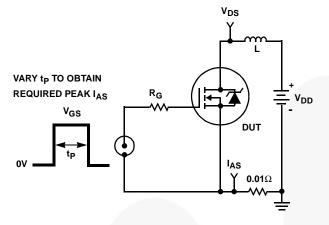


FIGURE 14. UNCLAMPED ENERGY TEST CIRCUIT

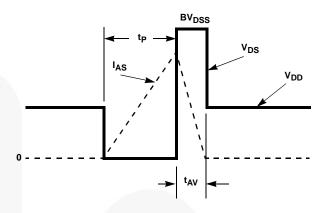


FIGURE 15. UNCLAMPED ENERGY WAVEFORMS

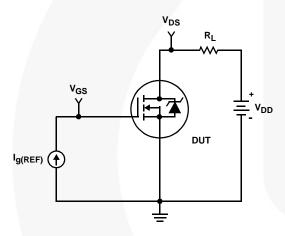


FIGURE 16. GATE CHARGE TEST CIRCUIT

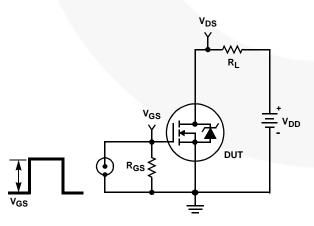
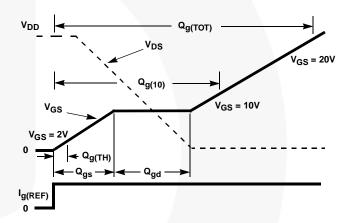


FIGURE 18. SWITCHING TIME TEST CIRCUIT





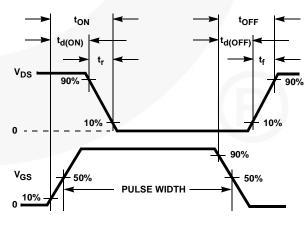
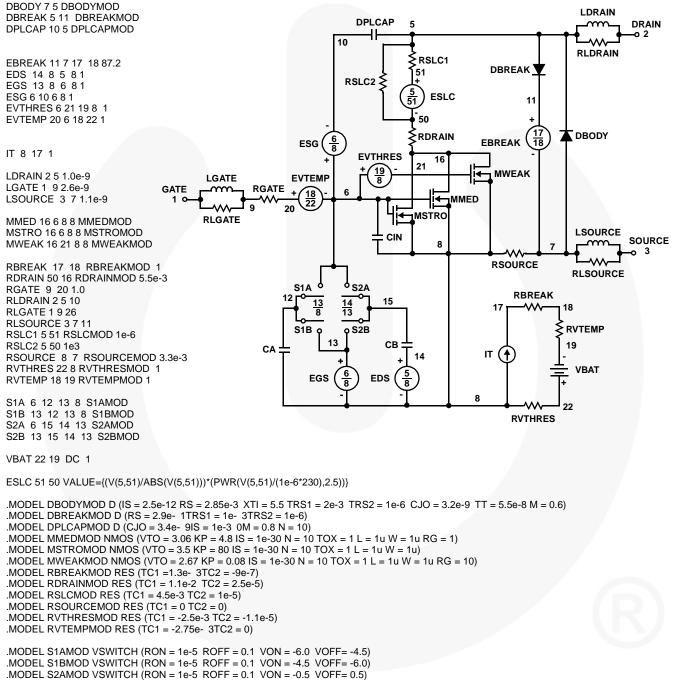


FIGURE 19. SWITCHING TIME WAVEFORM

PSPICE Electrical Model

.SUBCKT HUF75542P3 2 1 3 ; rev 15 Feb 2000

CA 12 8 4.4e-9 CB 15 14 4.2e-9 CIN 6 8 2.5e-9



.MODEL S2BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 0.5 VOFF= -0.5)

.ENDS

NOTE: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.

SABER Electrical Model REV 15 Feb 00 template huf75542p3 n2,n1,n3 electrical n2,n1,n3 var i iscl dp..model dbodymod = (is = 2.5e-12, rs = 2.85e-3, xti = 5.5, trs1 = 2e-3, trs2 = 1e-6, cjo = 3.2e-9, tt = 5.5e-8, m = 0.6) dp..model dbreakmod = (rs = 2.9e-1, trs1 = 1e-3, trs2 = 1e-6) dp..model dplcapmod = (cjo = 3.4e-9, is = 1e-30, m = 0.8, nl = 10) m..model mmedmod = (type=_n, vto = 3.06, kp = 4.8, is = 1e-30, tox = 1) m..model mstrongmod = (type=_n, vto = 3.5, kp = 80, is = 1e-30, tox = 1) m..model mweakmod = (type=_n, vto = 2.67, kp = 0.08, is = 1e-30, tox = 1) sw_vcsp..model s1amod = (ron = 1e-5, roff = 0.1, von = -6.0, voff = -4.5) DPLCAP 5 sw vcsp..model s1bmod = (ron =1e-5, roff = 0.1, von = -4.5, voff = -6.0) 10 sw_vcsp..model s2amod = (ron = 1e-5, roff = 0.1, von = -0.5, voff = 0.5) sw_vcsp..model s2bmod = (ron = 1e-5, roff = 0.1, von = 0.5, voff = -0.5) RSLC1 51 c.ca n12 n8 = 4.4e-9 RSLC2 ≥ c.cb n15 n14 = 4.2e-9 ISCL c.cin n6 n8 = 2.5e-9 dp.dbody n7 n5 = model=dbodymod 50 dp.dbreak n5 n11 = model=dbreakmod RDRAIN dp.dplcap n10 n5 = model=dplcapmod 6 8 ESG EVTHRES 16 i.it n8 n17 = 1 21 19 8 EVTEMP LGATE I.ldrain n2 n5 = 1e-9 RGATE GATE 6 18 22 l.lgate n1 n9 = 2.6e-9 1 I 9 \sim 20 I.Isource n3 n7 = 1.1e-9 MSTR RLGATE m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u CIN 8 m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u res.rbreak n17 n18 = 1, tc1 = 1.3e-3, tc2 = -9e-7 o S2A S1A res.rdrain n50 n16 = 5.5e-3, tc1 = 1.1e-2, tc2 = 2.5e-5 <u>13</u> 8 <u>14</u> 13 15 res.rgate n9 n20 = 1.0res ridrain n2 n5 = 10 res.rlgate n1 n9 = 26 o S2B S1B res.rlsource n3 n7 = 11 СВ CA res.rslc1 n5 n51 = 1e-6, tc1 = 4.5e-3, tc2 = 1e-5 14 res.rslc2 n5 n50 = 1e3 res.rsource n8 n7 = 3.3e-3, tc1 = 0, tc2 = 0 <u>6</u> 8 5 EGS EDS res.rvtemp n18 n19 = 1, tc1 = -2.75e-3, tc2 = 0 res.rvthres n22 n8 = 1, tc1 = -2.5e-3, tc2 = -1.1e-5 spe.ebreak n11 n7 n17 n18 = 87.2

spe.eds n14 n8 n5 n8 = 1 spe.egs n13 n8 n6 n8 = 1 spe.esg n6 n10 n6 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1 spe.evthres n6 n21 n19 n8 = 1

sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw vcsp.s2a n6 n15 n14 n13 = model=s2amod sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod

v.vbat n22 n19 = dc=1

equations { i (n51->n50) +=iscl iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/230))**2.5))

©2001 Fairchild Semiconductor Corporation

LDRAIN

RLDRAIN

DBODY

LSOURCE

RLSOURCE

18

19

22

RVTEMP

VBAT

DBREAK

MWEAK

EBREAK

RSOURCE

17

IT (♠

8

RBREAK

RVTHRES

MMED

11

DRAIN

SOURCE

3

o 2

SPICE Thermal Model

REV 15 Feb 00

T75542

CTHERM1 th 6 4.1e-3 CTHERM2 6 5 5.5e-3 CTHERM3 5 4 8.6e-3 CTHERM4 4 3 1.5e-2 CTHERM5 3 2 1.6e-2 CTHERM6 2 tl 6.5e-2

RTHERM1 th 6 2.0e-4 RTHERM2 6 5 3.5e-3 RTHERM3 5 4 2.5e-2 RTHERM4 4 3 9.0e-2 RTHERM5 3 2 1.6e-1 RTHERM6 2 tl 2.3e-1

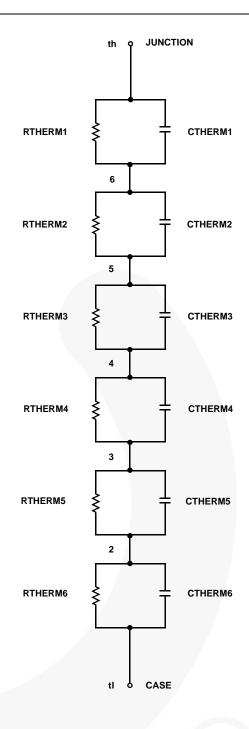
SABER Thermal Model

SABER thermal model t75542

template thermal_model th tl thermal_c th, tl

ctherm.ctherm1 th 6 = 4.1e-3ctherm.ctherm2 6 5 = 5.5e-3ctherm.ctherm3 5 4 = 8.6e-3ctherm.ctherm4 4 3 = 1.5e-2ctherm.ctherm5 3 2 = 1.6e-2ctherm.ctherm6 2 tl = 6.5e-2

rtherm.rtherm1 th 6 = 2.0e-4 rtherm.rtherm2 6 5 = 3.5e-3 rtherm.rtherm3 5 4 = 2.5e-2 rtherm.rtherm4 4 3 = 9.0e-2 rtherm.rtherm5 3 2 = 1.6e-1 rtherm.rtherm6 2 tl = 2.3e-1 }



FAIRCHIL

SEMICONDUCTOR

TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

AccuPower TM AX-CAP [®] * BitSiC TM Build it Now TM CorePLUS TM CorePOWER TM <i>CROSSVOLT</i> TM CTL TM CUrrent Transfer Logic TM DEUXPEED [®] Dual Cool TM EcoSPARK [®] EfficentMax TM ESBC TM Fairchild [®] Fairchild [®] Fairchild [®] Fairchild [®] Fairchild [®] Fairchild [®] Fairchild [®] Fairchild [®] Fast [®] FAST [®] FAST [®] FastvCore TM FETBench TM FPS TM	F-PFS™ FRFET® Global Power Resource SM Green Bridge™ Green FPS™ Green FPS™ Gmax™ GTO™ IntelliMAX™ ISOPLANAR™ Marking Small Speakers Sound Loud and Better™ MegaBuck™ MicroPak™ MicroPak™ MicroPak™ MicroPak™ MicroPak™ MicroPak™ MicroPak™ MicroPak™ MillerDrive™ MotionMax™ mWSaver® OptoHiT™ OPTOLOGIC® OPTOPLANAR®	PowerTrench® PowerXS™ Programmable Active Droop™ QFET® QS™ Quiet Series™ RapidConfigure™ Programmable Active Droop™ QFET® Saving our world, 1mW/W/kW at a time™ Saving our world, 1mW/W/kW at a time™ SignalWise™ Saving our world, 1mW/W/kW at a time™ Saving our world, 1mW/W/kW at a time Saving our wo	Sync-Lock TM SYSTEM $^{\otimes*}$ GENERAL TinyBoost $^{\otimes}$ TinyBuck $^{\otimes}$ TinyCalc TM TinyCogic $^{\otimes}$ TinyOPTO TM TinyPOWET TM TinyPWM TM TranSiC TM TriFault Detect TM TRUECURRENT $^{\otimes}*$ UECURRENT $^{\otimes}*$ UHC $^{\otimes}$ UHC $^{\otimes}$ UITA FRFET TM UniFET TM VCX TM VisualMax TM VoltagePlus TM XS TM
---	--	---	---

*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used here in:

- Life support devices or systems are devices or systems which, (a) are 1. intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or 2. system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor has against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death ass

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC